

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	WO 00/75151 A1	12-2000	International	Resconi et al.	C07F 17/00
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#### NON-PATENT DOCUMENTS

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	U	Balboni et al. Inorg. Chem. 2001, 40, 6588-6597.
	V	Resconi et al. Organometallics, 2000, 19, 420-429.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.